# N-Channel Power MOSFET 500 V, 0.85 $\Omega$

#### Features

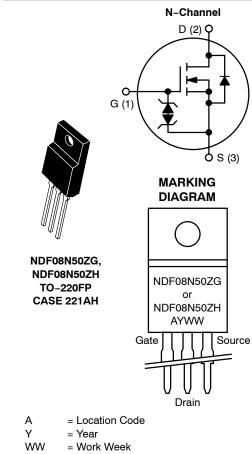
- Low ON Resistance
- Low Gate Charge
- ESD Diode-Protected Gate
- 100% Avalanche Tested
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant



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| V <sub>DSS</sub> | R <sub>DS(ON)</sub> (MAX) @ 3.6 A |
|------------------|-----------------------------------|
| 500 V            | 0.85 Ω                            |



G, H = Pb-Free, Halogen-Free Package

#### ORDERING INFORMATION

| Device     | Package                                | Shipping        |
|------------|--|-----------------|
| NDF08N50ZG | TO-220FP<br>(Pb-Free,<br>Halogen-Free) | 50 Units / Rail |
| NDF08N50ZH | TO-220FP<br>(Pb-Free,<br>Halogen-Free) | 50 Units / Rail |

#### ABSOLUTE MAXIMUM RATINGS (T\_C = 25°C unless otherwise noted)

| Rating   | Symbol                            | NDF08N50Z  | Unit |
|--|-----------------------------------|------------|------|
| Drain-to-Source Voltage  | V <sub>DSS</sub>                  | 500        | V    |
| Continuous Drain Current $R_{\theta JC}$ (Note 1)  | Ι <sub>D</sub>                    | 8.5        | А    |
| Continuous Drain Current $R_{\theta JC}$<br>T <sub>A</sub> = 100°C (Note 1)  | ۱ <sub>D</sub>                    | 5.4        | A    |
| Pulsed Drain Current,<br>V <sub>GS</sub> @ 10 V  | I <sub>DM</sub>                   | 34         | A    |
| Power Dissipation  | PD                                | 35         | W    |
| Gate-to-Source Voltage   | V <sub>GS</sub>                   | ±30        | V    |
| Single Pulse Avalanche Energy, $I_D = 7.5 \text{ A}$   | E <sub>AS</sub>                   | 190        | mJ   |
| ESD (HBM)<br>(JESD 22–A114)  | V <sub>esd</sub>                  | 3500       | V    |
| $\label{eq:RMS} \begin{array}{l} \text{RMS Isolation Voltage} \\ (t=0.3 \; \text{sec.}, \; \text{R.H.} \leq 30\%, \\ T_{\text{A}} = 25^{\circ}\text{C}) \; (\text{Figure 14}) \end{array}$ | V <sub>ISO</sub>                  | 4500       | V    |
| Peak Diode Recovery (Note 2)   | dV/dt                             | 4.5        | V/ns |
| MOSFET dV/dt   | dV/dt                             | 60         | V/ns |
| Continuous Source Current (Body Diode)   | I <sub>S</sub>                    | 7.5        | A    |
| Maximum Temperature for Soldering Leads  | ΤL                                | 260        | °C   |
| Operating Junction and<br>Storage Temperature Range  | T <sub>J</sub> , T <sub>stg</sub> | –55 to 150 | °C   |

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Limited by maximum junction temperature

2.  $I_{SD}$  = 7.5 Å, di/dt  $\leq$  100 Å/ $\mu s,$   $V_{DD}$   $\leq$   $BV_{DSS},$   $T_{J}$  = +150°C

#### THERMAL RESISTANCE

| Parameter                                 | Symbol          | NDF08N50Z | Unit |
|---|-----------------|-----------|------|
| Junction-to-Case (Drain)                  | $R_{\theta JC}$ | 3.6       | °C/W |
| Junction-to-Ambient Steady State (Note 3) | $R_{\theta JA}$ | 50        |      |

3. Insertion mounted

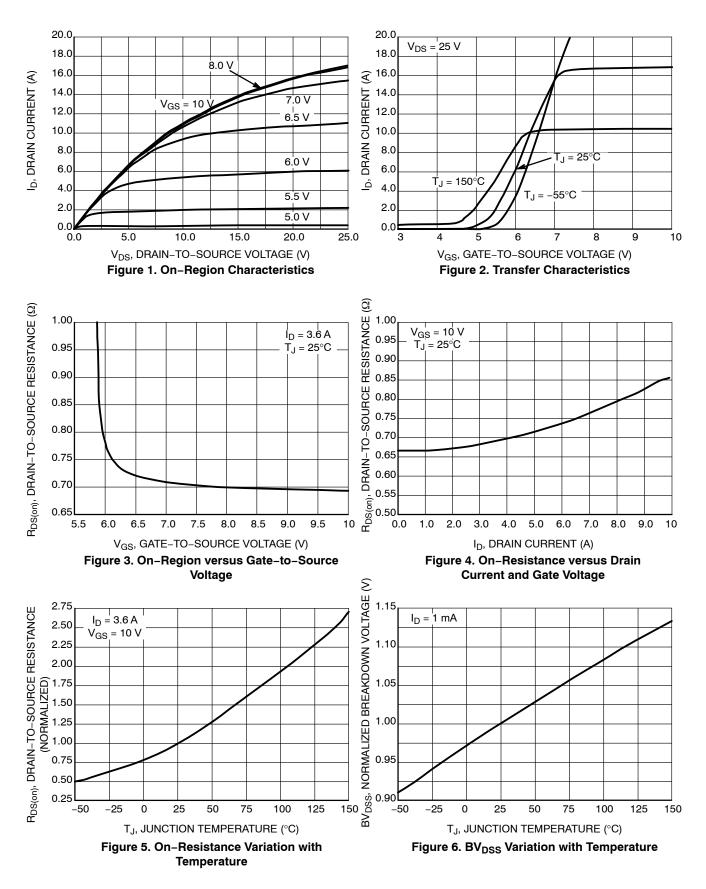
#### **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise noted)

| Characteristic                                 | Test Conditions  |            | Symbol                       | Min | Тур  | Max  | Unit |
|--|--|------------|------------------------------|-----|------|------|------|
| OFF CHARACTERISTICS                            |  |            | -                            |     | -    | -    | -    |
| Drain-to-Source Breakdown Voltage              | $V_{GS}$ = 0 V, I <sub>D</sub> = 1 mA                            |            | BV <sub>DSS</sub>            | 500 |      |      | V    |
| Breakdown Voltage Temperature Co-<br>efficient | Reference to 25°C,<br>I <sub>D</sub> = 1 mA                      |            | $\Delta BV_{DSS}/\Delta T_J$ |     | 0.6  |      | V/°C |
| Drain-to-Source Leakage Current                | V <sub>DS</sub> = 500 V, V <sub>GS</sub> = 0 V                   | 25°C       | I <sub>DSS</sub>             |     |      | 1    | μA   |
|  |  | 150°C      |                              |     |      | 50   | 1    |
| Gate-to-Source Forward Leakage                 | V <sub>GS</sub> = ±20 V  |            | I <sub>GSS</sub>             |     |      | ±10  | μA   |
| ON CHARACTERISTICS (Note 4)                    |  |            | •                            |     | -    | •    |      |
| Static Drain-to-Source<br>On-Resistance        | $V_{GS}$ = 10 V, $I_{D}$ = 3.6 A                                 |            | R <sub>DS(on)</sub>          |     | 0.69 | 0.85 | Ω    |
| Gate Threshold Voltage                         | $V_{DS}$ = $V_{GS}$ , $I_D$ = 100 $\mu$ A                        |            | V <sub>GS(th)</sub>          | 3.0 | 3.9  | 4.5  | V    |
| Forward Transconductance                       | V <sub>DS</sub> = 15 V, I <sub>D</sub> = 3.75 A                  |            | 9fs                          |     | 6.0  |      | S    |
| DYNAMIC CHARACTERISTICS                        |  |            |                              |     |      |      | -    |
| Input Capacitance (Note 5)                     | V <sub>DS</sub> = 25 V, V <sub>GS</sub> = 0 V,<br>f = 1.0 MHz    |            | C <sub>iss</sub>             | 730 | 912  | 1095 | pF   |
| Output Capacitance (Note 5)                    |  |            | C <sub>oss</sub>             | 95  | 120  | 140  |      |
| Reverse Transfer Capacitance<br>(Note 5)       |  |            | C <sub>rss</sub>             | 15  | 27   | 35   |      |
| Total Gate Charge (Note 5)                     |  |            | Qg                           | 16  | 31   | 46   | nC   |
| Gate-to-Source Charge (Note 5)                 |  |            | Q <sub>gs</sub>              | 3   | 6.2  | 9    | 1    |
| Gate-to-Drain ("Miller") Charge<br>(Note 5)    | $V_{DD}$ = 250 V, I_D = 7.5 A, $V_{\rm GS}$ = 10 V               |            | Q <sub>gd</sub>              | 8   | 17   | 25   |      |
| Plateau Voltage                                |  |            |                              |     | 6.3  |      | V    |
| Gate Resistance                                |  |            | R <sub>g</sub>               |     | 3.0  |      | Ω    |
| RESISTIVE SWITCHING CHARACTER                  | RISTICS  |            |                              |     |      |      |      |
| Turn-On Delay Time                             |  |            | t <sub>d(on)</sub>           |     | 13   |      | ns   |
| Rise Time                                      | $V_{DD}$ = 250 V, I_D = 7.5 A, $V_{GS}$ = 10 V, R_G = 5 $\Omega$ |            | t <sub>r</sub>               |     | 23   |      |      |
| Turn-Off Delay Time                            |  |            | t <sub>d(off)</sub>          |     | 31   |      | 1    |
| Fall Time                                      |  |            | t <sub>f</sub>               |     | 29   |      | 1    |
| SOURCE-DRAIN DIODE CHARACTE                    | <b>RISTICS</b> (T <sub>C</sub> = 25°C unless oth                 | nerwise no | ted)                         |     | •    |      |      |
|  |  |            | ,                            |     | 1    | 1    |      |

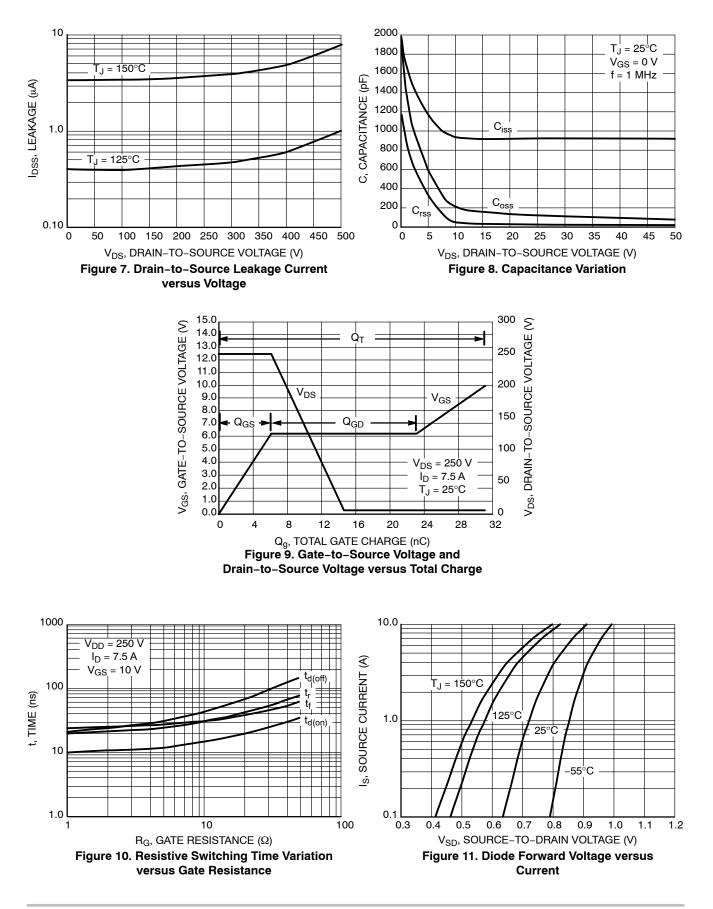
| Diode Forward Voltage   | $I_{\rm S}$ = 7.5 A, $V_{\rm GS}$ = 0 V       | V <sub>SD</sub> |      | 1.6 | V  |
|-------------------------|---|-----------------|------|-----|----|
| Reverse Recovery Time   | V <sub>GS</sub> = 0 V, V <sub>DD</sub> = 30 V | t <sub>rr</sub> | 295  |     | ns |
| Reverse Recovery Charge | I <sub>S</sub> = 7.5 A, di/dt = 100 A/μs      | Q <sub>rr</sub> | 1.85 |     | μC |

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.
4. Pulse Width ≤ 380 µs, Duty Cycle ≤ 2%.
5. Guaranteed by design.

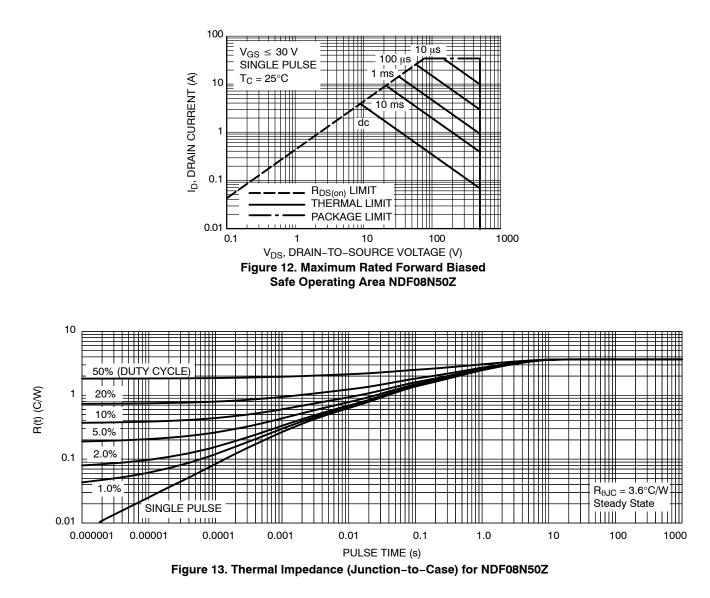
#### **TYPICAL CHARACTERISTICS**

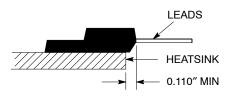


#### **TYPICAL CHARACTERISTICS**



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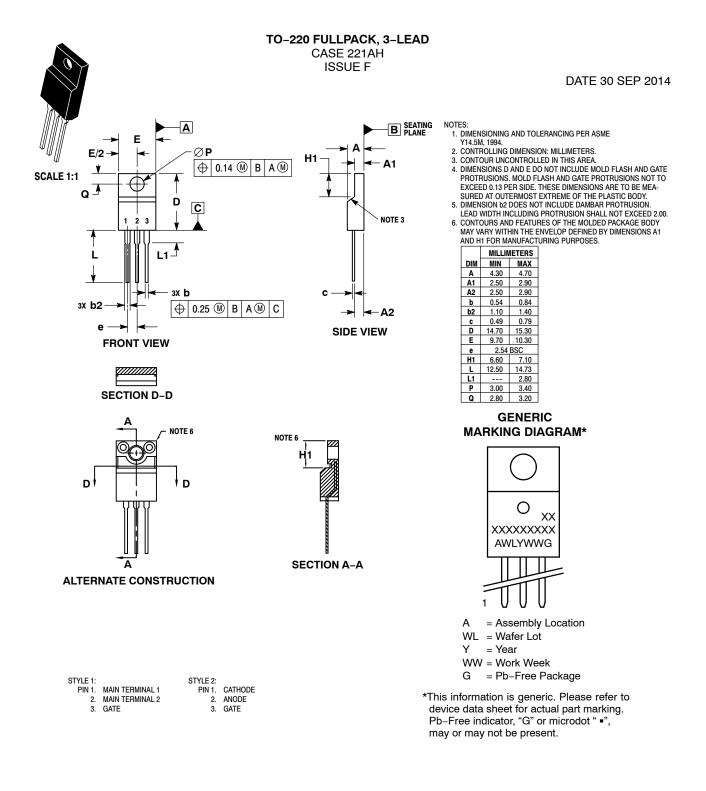


#### Figure 14. Isolation Test Diagram

Measurement made between leads and heatsink with all leads shorted together.

\*For additional mounting information, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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